

- ◊ STRUCTURE Silicon Monolithic Integrated Circuit  
 ◊ PRODUCT SPI BUS Serial EEPROMs  
 ◊ SERIES ADVANTAGE SERIES  
 ◊ FAMILY BR25□□0 family  
 ◊ TYPE Supply voltage 2.7V~5.5V/Opreating temperature -40°C~+85°Ctype  
 ◊ PART NUMBER BR25□□0-10□U-2.7

PART NUMBER	PACKAGE	DENSITY
BR25010N-10SU-2.7	8-lead JEDEC SOIC	1Kbit
BR25020N-10SU-2.7		2Kbit
BR25040N-10SU-2.7		4Kbit
BR25080N-10SU-2.7		8Kbit
BR25160N-10SU-2.7		16Kbit
BR25320N-10SU-2.7		32Kbit
BR25640N-10SU-2.7		64Kbit
BR25010-10TU-2.7	8-lead TSSOP	1Kbit
BR25020-10TU-2.7		2Kbit
BR25040-10TU-2.7		4Kbit
BR25080-10TU-2.7		8Kbit
BR25160-10TU-2.7		16Kbit

- ◊ FEATURES SPI BUS interface  
 Endurance : 1,000,000 erase/write cycles  
 Data retention : 100 years  
 Intial Data: Memory array FFh

◊ ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Min.	Max.	Unit
T <sub>STG</sub>	Storage Temperature	-65	125	°C
V <sub>IN</sub>	Input range	-0.3	V <sub>CC</sub> +0.3	V
V <sub>CC</sub>	Supply Voltage	-0.3	6.5	V

◊ POWER DISSIPATION (Ta=25°C)

PACKAGE	Rating	Unit
8-lead JEDEC SOIC	450 *1	mW
8-lead TSSOP	330 *2	mW

\* Degradation is done at 4.5mW/°C(\*1), 3.3mW/°C(\*2)for operation above 25°C

## ◇ DC OPERATING CHARACTERISTICS

(BR25010/020/040, Unless otherwise specified,  $T_A=40^\circ\text{C}$  to  $85^\circ\text{C}$ ,  $VCC=+2.7\text{V}$  to  $+5.5\text{V}$ )

Parameter	Symbol	Specification			Units	Test Conditions
		Min.	Typ.	Max.		
Supply Current	$I_{CC1}$	-	-	3.0	mA	$Vcc=5.0\text{V}, f_{SCK}=1\text{MHz}$ , SO=Open, Read
Supply Current	$I_{CC2}$	-	-	6.0	mA	$Vcc=5.0\text{V}, f_{SCK}=2\text{MHz}$ , SO=Open, Read, Write
Standby Current	$I_{SB1}$	-	-	5.0	$\mu\text{A}$	$Vcc=2.7\text{V}, CS=HOLD=WP=Vcc$ , $SCK=SI=Vcc$ or GND, SO=OPEN
Standby Current	$I_{SB2}$	-	-	10.0	$\mu\text{A}$	$Vcc=5.0\text{V}, CS=HOLD=WP=Vcc$ , $SCK=SI=Vcc$ or GND, SO=OPEN
Input Leakage	$I_{IN}$	-0.8	-	3.0	$\mu\text{A}$	$V_B=0\text{V} \sim Vcc$
Output Leakage	$I_{OL}$	-0.8	-	3.0	$\mu\text{A}$	$V_B=0\text{V} \sim Vcc, T_{AC}=0^\circ\text{C} \sim 70^\circ\text{C}$
Input Low Voltage	$V_{IL}$	-	-	$V_{CC} \times 0.3$	V	-
Input High Voltage	$V_{IH}$	$V_{CC} \times 0.7$	-	-	V	-
Output Low Voltage	$V_{OL1}$	-	-	0.4	V	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $I_{OL}=2.0\text{mA}$
Output High Voltage	$V_{OH1}$	$V_{CC} \times 0.8$	-	-	V	$I_{OL}=1.0\text{mA}$
Output Low Voltage	$V_{OL2}$	-	-	0.2	V	$I_{OL}=0.15\text{mA}$
Output High Voltage	$V_{OH2}$	$V_{CC} \times 0.2$	-	-	V	$2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $I_{OH}=100\text{ }\mu\text{A}$

## ◇ DC OPERATING CHARACTERISTICS

(BR25080/180/320/640, Unless otherwise specified,  $T_A=40^\circ\text{C}$  to  $85^\circ\text{C}$ ,  $VCC=+2.7\text{V}$  to  $+5.5\text{V}$ )

Parameter	Symbol	Specification			Units	Test Conditions
		Min.	Typ.	Max.		
Supply Current	$I_{CC1}$	-	-	3.0	mA	$Vcc=5.0\text{V}, f_{SCK}=1\text{MHz}$ , SO=Open, Read
Supply Current	$I_{CC2}$	-	-	5.0	mA	$Vcc=5.0\text{V}, f_{SCK}=2\text{MHz}$ , SO=Open, Read, Write
Standby Current	$I_{SB1}$	-	0.2	2.0	$\mu\text{A}$	$Vcc=2.7\text{V}, CS=HOLD=WP=Vcc$ , $SCK=SI=Vcc$ or GND, SO=OPEN
Standby Current	$I_{SB2}$	-	2.0	5.0	$\mu\text{A}$	$Vcc=5.0\text{V}, CS=HOLD=WP=Vcc$ , $SCK=SI=Vcc$ or GND, SO=OPEN
Input Leakage	$I_{IN}$	-3.0	-	3.0	$\mu\text{A}$	$V_B=0\text{V} \sim Vcc$
Output Leakage	$I_{OL}$	-3.0	-	3.0	$\mu\text{A}$	$V_B=0\text{V} \sim Vcc, T_{AC}=0^\circ\text{C} \sim 70^\circ\text{C}$
Input Low Voltage	$V_{IL}$	-	-	$V_{CC} \times 0.3$	V	-
Input High Voltage	$V_{IH}$	$V_{CC} \times 0.7$	-	-	V	-
Output Low Voltage	$V_{OL1}$	-	-	0.4	V	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $I_{OL}=3.0\text{mA}$
Output High Voltage	$V_{OH1}$	$V_{CC} \times 0.8$	-	-	V	$I_{OL}=1.6\text{mA}$
Output Low Voltage	$V_{OL2}$	-	-	0.2	V	$I_{OL}=0.15\text{mA}$
Output High Voltage	$V_{OH2}$	$V_{CC} \times 0.2$	-	-	V	$2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $I_{OH}=100\text{ }\mu\text{A}$

## ◇ AC OPERATING CHARACTERISTICS

(BR25010/020/040, Unless otherwise specified,  $T_A=40^\circ\text{C}$  to  $85^\circ\text{C}$ ,  $VCC=+2.7\text{V}$  to  $+5.5\text{V}$ ,  $C_L=100\text{pF}$ )

Parameter	Symbol	Specification			Unit	Test Condition
		Min.	Typ.	Max.		
SCK Clock Frequency	$f_{SCK}$	0	-	3.0	MHz	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		0	-	2.1		
		0	-	0.5		
Input Rise Time	$t_{RI}$	-	-	2	$\mu\text{s}$	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		-	-	2		
Input Fall Time	$t_{RF}$	-	-	2	$\mu\text{s}$	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		-	-	2		
SCK High Time	$t_{WH}$	133	-	-	ns	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		200	-	-		
		800	-	-		
SCK Low Time	$t_{WL}$	133	-	-	ns	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		200	-	-		
		800	-	-		
CS High Time	$t_{CH}$	250	-	-	ns	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		250	-	-		
		1000	-	-		
CS Setup Time	$t_{CSS}$	250	-	-	ns	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		250	-	-		
		1000	-	-		
CS Hold Time	$t_{CSH}$	250	-	-	ns	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		250	-	-		
		1000	-	-		
Data In Setup Time	$t_{SIU}$	50	-	-	ns	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		50	-	-		
		100	-	-		
Data In Hold Time	$t_{SH}$	50	-	-	ns	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		100	-	-		
		100	-	-		
Hold Setup Time	$t_{HD}$	100	-	-	ns	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		100	-	-		
		400	-	-		
Hold Hold Time	$t_{HOH}$	200	-	-	ns	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		200	-	-		
		400	-	-		
Output Valid	$t_{V}$	0	-	133	$\mu\text{s}$	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		0	-	200		
		0	-	800		
Output Hold Time	$t_{VOH}$	0	-	-	ns	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		0	-	-		
		0	-	-		
Hold to Output Low Z	$t_{LZ}$	0	-	100	$\mu\text{s}$	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		0	-	100		
		0	-	100		
Hold to Output High Z	$t_{HQZ}$	-	-	100	$\mu\text{s}$	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		-	-	100		
Output Disable Time	$t_{ODS}$	-	-	250	$\mu\text{s}$	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		-	-	500		
		-	-	1000		
Write Cycle Time	$t_{WC}$	-	-	5	ms	$4.5\text{V} \leq Vcc \leq 5.5\text{V}$ , $2.7\text{V} \leq Vcc \leq 5.5\text{V}$ , $1.8\text{V} \leq Vcc \leq 5.5\text{V}$
		-	-	10		
		-	-	20		
Endurance *1 5.0V, 25°C, Page Mode	-	-	1M	-	-	Write Cycles

\*1 This parameter is characterized and is not 100% tested.

O This product is not designed for protection against radioactive rays.

## ◇ BLOCK DIAGRAM

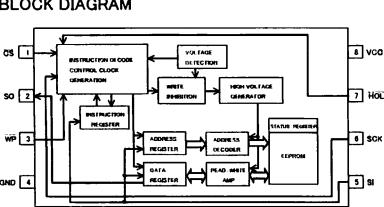
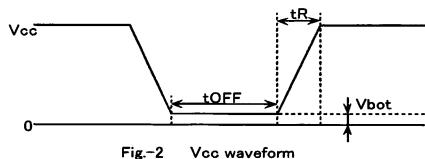


Fig.1 BLOCK DIAGRAM

### ◊NOTES FOR POWER SUPPLY

In order to prevent an inadvertent write, the device has the feature of P.O.R.

After the power is on, the device is in the write disable mode. P.O.R. works only during power up. The noise may force the device write enable mode with  $\overline{CS} = "H"$  during power ON/OFF. In the case of power up, keep the following conditions to ensure to make the function of P.O.R.



### ◊RECOMMENDED CONDITIONS OF tR, tOFF, Vbot

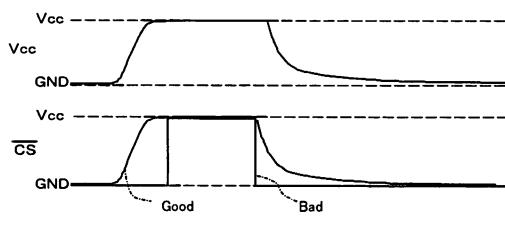
tR	tOFF	Vbot
Below 10ms	Above 10ms	Below 0.3V
Below 100ms	Above 10ms	Below 0.2V

Please keep  $\overline{CS}$  "H" during power ON/OFF.

The device is an active state during  $\overline{CS}$  is low. The extraordinary function or data collaption may occur because of noise etc., if power-up is done with  $\overline{CS}$  "L". In order to prevent above errors from happening, keep  $\overline{CS}$  "H" ( $=V_{CC}$ ) during power ON. (The device does not receive any command during  $\overline{CS}$  is high.)

It may continue at low  $V_{CC}$  by capacitance of  $V_{CC}$  line during power off.

Please keep  $\overline{CS}$  "H" during power off because of the device may make malfunction and inadvertent write.



### (Good example)

$\overline{CS}$  follows  $V_{CC}$ . ( $\overline{CS}$  is pull up to  $V_{CC}$ )

### (Bad example)

$\overline{CS}$  is low during power ON/OFF.

Please take more than 10ms between power ON and power OFF, or the internal circuit is not always reset.

### ◊CAUTIONS ON USE

#### (1) Absolute maximum ratings

If the absolute maximum ratings such as impressed voltage and action temperature range and so forth are exceeded, LSI may be destructed. Do not impress voltage and temperature exceeding the absolute maximum ratings. In the case of fear exceeding the absolute maximum ratings, take physical safety countermeasures such as fuses, and see to it that conditions exceeding the absolute maximum ratings should not be impressed to LSI.

#### (2) GND electric potential

Set the voltage of GND terminal lowest at any action condition. Make sure that each terminal voltage is lower than that of GND terminal.

#### (3) Thermal design

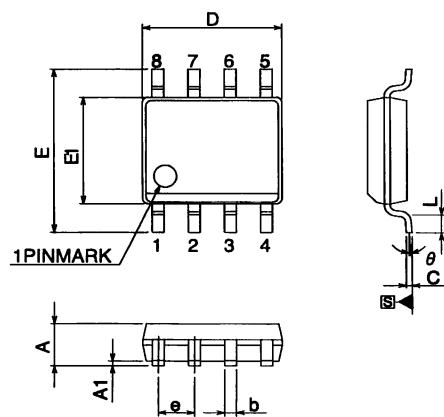
In consideration of permissible loss in actual use condition, carry out heat design with sufficient margin.

#### (4) Terminal to terminal shortcircuit and wrong packaging

When to package LSI onto a board, pay sufficient attention to LSI direction and displacement. Wrong packaging may destruct LSI. And in the case of shortcircuit between LSI terminals and terminals and power source, terminal and GND owing to foreign matter, LSI may be destructed.

#### (5) Use in a strong electromagnetic field may cause malfunction, therefore, evaluated design sufficiently.

## ◊ PHYSICAL DIMENSION

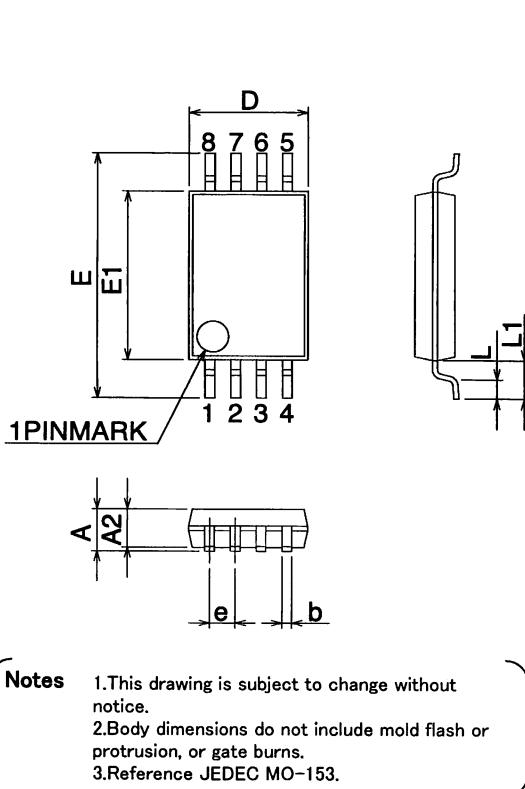


- Notes**
- 1.This drawing is subject to change without notice.
  - 2.Body dimensions do not include mold flash or protrusion, or gate burns.
  - 3.Reference JEDEC MS-012 variation AA.

Fig.-4 8-lead JEDEC SOIC Package Outline

## ◊ 8-lead JEDEC SOIC Package Size Data

Symbol	mm			inches		
	Typ.	Min.	Max	Typ.	Min.	Max
A	-	1.35	1.75	-	0.053	0.069
A1	-	0.10	0.25	-	0.004	0.010
b	-	0.31	0.51	-	0.012	0.020
c	-	0.17	0.25	-	0.007	0.010
D	-	4.80	5.00	-	0.189	0.197
e	1.27 BSC	-	-	0.050 BSC	-	-
E	-	5.79	6.20	-	0.228	0.244
E1	-	3.81	3.99	-	0.150	0.157
L	-	0.40	1.27	-	0.016	0.050
θ	-	0°	8°	-	0°	8°



- Notes**
- 1.This drawing is subject to change without notice.
  - 2.Body dimensions do not include mold flash or protrusion, or gate burns.
  - 3.Reference JEDEC MO-153.

Fig.-5 8-lead TSSOP Package Outline

## ◊ 8-lead TSSOP Package Size Data

Symbol	mm			inches		
	Typ.	Min.	Max	Typ.	Min.	Max
A	-	-	1.20	-	-	0.047
A2	1.00	0.80	1.05	0.039	0.031	0.041
b	-	0.19	0.30	-	0.007	0.012
D	3.00	2.90	3.10	0.118	0.114	0.122
e	0.65 BSC	-	-	0.025	-	-
E	6.40 BSC	-	-	0.252	-	-
E1	4.40	4.30	4.50	0.173	0.169	0.177
L	0.60	0.45	0.75	0.023	0.017	0.030
L1	1.00 BSC	-	-	0.039	-	-

## Appendix

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Beijing	TEL : +86(10)8525-2483	FAX : +86(10)8525-2489
Taiwan / Taipei	TEL : +866(2)2500-6956	FAX : +866(2)2503-2869
Korea / Seoul	TEL : +82(2)8182-700	FAX : +82(2)8182-715
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Malaysia / Kuala Lumpur	TEL : +60(3)7958-8355	FAX : +60(3)7958-8377
Philippines / Manila	TEL : +63(2)807-6872	FAX : +63(2)809-1422
Thailand / Bangkok	TEL : +66(2)254-4890	FAX : +66(2)256-6334

Japan /  
(Internal Sales)

Tokyo	2-1-1, Yaesu, Chuo-ku, Tokyo 104-0082 TEL : +81(3)5203-0321	FAX : +81(3)5203-0300
Yokohama	2-4-8, Shin Yokohama, Kohoku-ku, Yokohama, Kanagawa 222-8575 TEL : +81(45)476-2131	FAX : +81(45)476-2128
Nagoya	Dainagayo Building 9F 3-28-12, Meieki, Nakamura-ku, Nagoya,Aichi 450-0002 TEL : +81(52)581-8521	FAX : +81(52)561-2173
Kyoto	579-32 Higashi Shiokouji-cho, Karasuma Nishi-iru, Shiokujidori, Shimogyo-ku, Kyoto 600-8216 TEL : +81(75)311-2121	FAX : +81(75)314-6559

(Contact address for overseas customers in Japan)

Yokohama TEL : +81(45)476-9270 FAX : +81(045)476-9271